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# R1RP0416DI Series

Wide Temperature Range Version 4M High Speed SRAM (256-kword × 16-bit)

REJ03C0110-0100Z Rev. 1.00 Mar.12.2004

#### **Description**

The R1RP0416DI Series is a 4-Mbit high speed static RAM organized 256-k word  $\times$  16-bit. It has realized high speed access time by employing CMOS process (6-transistor memory cell) and high speed circuit designing technology. It is most appropriate for the application which requires high speed, high density memory and wide bit width configuration, such as cache and buffer memory in system. It is packaged in 400-mil 44-pin plastic SOJ and 400-mil 44-pin plastic TSOPII.

#### **Features**

• Single 5.0 V supply:  $5.0 \text{ V} \pm 10\%$ 

Access time: 12 ns (max)Completely static memory

completely state memory

No clock or timing strobe required

• Equal access and cycle times

• Directly TTL compatible

— All inputs and outputs

• Operating current: 160 mA (max)

• TTL standby current: 40 mA (max)

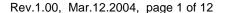
• CMOS standby current: 5 mA (max)

• Center V<sub>cc</sub> and V<sub>ss</sub> type pin out

• Temperature range:  $-40 \text{ to } +85^{\circ}\text{C}$ 

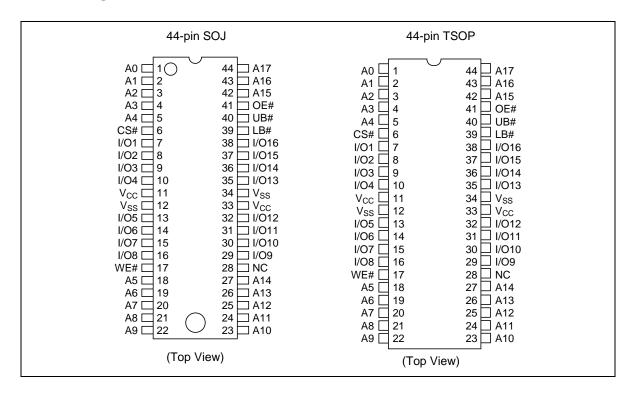
#### **Ordering Information**

Type No.	Access time	Package
R1RP0416DGE-2PI	12 ns	400-mil 44-pin plastic SOJ (44P0K)
R1RP0416DSB-2PI	12 ns	400-mil 44-pin plastic TSOPII (44P3W-H)





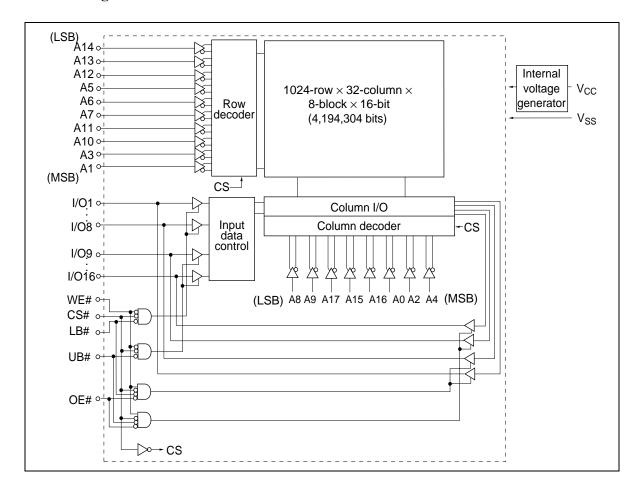
#### **Pin Arrangement**



#### **Pin Description**

Pin name	Function	
A0 to A17	Address input	
I/O1 to I/O16	Data input/output	
CS#	Chip select	
OE#	Output enable	
WE#	Write enable	
UB#	Upper byte select	
LB#	Lower byte select	
V <sub>cc</sub>	Power supply	
$V_{ss}$	Ground	
NC	No connection	

#### **Block Diagram**



## **Operation Table**

CS#	OE#	WE#	LB#	UB#	Mode	$\mathbf{V}_{\mathrm{cc}}$ current	I/O1–I/O8	I/O9–I/O16	Ref. cycle
Н	×	×	×	×	Standby	I <sub>SB</sub> , I <sub>SB1</sub>	High-Z	High-Z	_
L	Н	Н	×	×	Output disable	I <sub>cc</sub>	High-Z	High-Z	_
L	L	Н	L	L	Read	I <sub>cc</sub>	Output	Output	Read cycle
L	L	Н	L	Н	Lower byte read	I <sub>cc</sub>	Output	High-Z	Read cycle
L	L	Н	Н	L	Upper byte read	I <sub>cc</sub>	High-Z	Output	Read cycle
L	L	Н	Н	Н	_	I <sub>cc</sub>	High-Z	High-Z	_
L	×	L	L	L	Write	I <sub>cc</sub>	Input	Input	Write cycle
L	×	L	L	Н	Lower byte write	I <sub>cc</sub>	Input	High-Z	Write cycle
L	×	L	Н	L	Upper byte write	I <sub>cc</sub>	High-Z	Input	Write cycle
L	×	L	Н	Н	_	I <sub>cc</sub>	High-Z	High-Z	_

Note: H:  $V_{IH}$ , L:  $V_{IL}$ ,  $\times$ :  $V_{IH}$  or  $V_{IL}$ 

## **Absolute Maximum Ratings**

Parameter	Symbol	Value	Unit
Supply voltage relative to V <sub>ss</sub>	V <sub>cc</sub>	-0.5 to +7.0	V
Voltage on any pin relative to V <sub>ss</sub>	V <sub>T</sub>	$-0.5^{*1}$ to $V_{cc} + 0.5^{*2}$	V
Power dissipation	P <sub>T</sub>	1.0	W
Operating temperature	Topr	-40 to +85	°C
Storage temperature	Tstg	-55 to +125	°C
Storage temperature under bias	Tbias	-40 to +85	°C

Notes: 1.  $V_T$  (min) = -2.0 V for pulse width (under shoot)  $\leq$  6 ns.

2.  $V_{\tau}$  (max) =  $V_{cc}$  + 2.0 V for pulse width (over shoot)  $\leq$  6 ns.

#### **Recommended DC Operating Conditions**

 $(Ta = -40 \text{ to } +85^{\circ}C)$ 

Parameter	Symbol	Min	Тур	Max	Unit
Supply voltage	V <sub>cc</sub> * <sup>3</sup>	4.5	5.0	5.5	V
	V <sub>SS</sub> * <sup>4</sup>	0	0	0	V
Input voltage	V <sub>IH</sub>	2.2	_	V <sub>cc</sub> + 0.5* <sup>2</sup>	V
	$\overline{V_{IL}}$	-0.5* <sup>1</sup>	_	0.8	V

Notes: 1.  $V_{\parallel}$  (min) = -2.0 V for pulse width (under shoot)  $\leq$  6 ns.

- 2.  $V_{IH}$  (max) =  $V_{CC}$  + 2.0 V for pulse width (over shoot)  $\leq$  6 ns.
- 3. The supply voltage with all  $\rm V_{\rm cc}$  pins must be on the same level.
- 4. The supply voltage with all  $V_{\rm ss}$  pins must be on the same level.

#### **DC** Characteristics

$$(Ta = -40 \text{ to } +85^{\circ}\text{C}, V_{CC} = 5.0 \text{ V} \pm 10\%, V_{SS} = 0 \text{ V})$$

Parameter	Symbol	Min	Max	Unit	Test conditions
Input leakage current	I <sub>LI</sub>	_	2	μΑ	$V_{IN} = V_{SS}$ to $V_{CC}$
Output leakage current*1	I <sub>LO</sub>	_	2	μΑ	$V_{IN} = V_{SS}$ to $V_{CC}$
Operating power supply current	I <sub>cc</sub>	_	160	mA	$CS\# = V_{IL}, I_{OUT} = 0 \text{ mA}$ $Other inputs = V_{IH}/V_{IL}$
Standby power supply current	l <sub>SB</sub>	_	40	mA	$CS\# = V_{iH},$ Other inputs = $V_{iH}/V_{iL}$
	I <sub>SB1</sub>	_	5	mA	$V_{cc} \ge CS\# \ge V_{cc} - 0.2 V$ ,
					(1) $0 \text{ V} \le V_{IN} \le 0.2 \text{ V or}$
					(2) $V_{CC} \ge V_{IN} \ge V_{CC} - 0.2 \text{ V}$
Output voltage	V <sub>oL</sub>	_	0.4	V	I <sub>OL</sub> = 8 mA
	V <sub>OH</sub>	2.4	_	V	$I_{OH} = -4 \text{ mA}$

#### Capacitance

$$(Ta = +25^{\circ}C, f = 1.0 \text{ MHz})$$

Parameter	Symbol	Min	Max	Unit	Test conditions
Input capacitance*1	C <sub>IN</sub>	_	6	pF	V <sub>IN</sub> = 0 V
Input/output capacitance*1	C <sub>I/O</sub>	_	8	pF	$V_{I/O} = 0 V$

Note: 1. This parameter is sampled and not 100% tested.



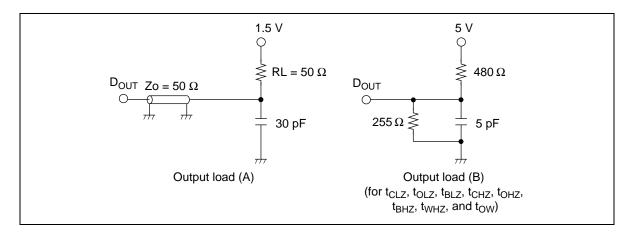
#### **AC Characteristics**

(Ta = -40 to +85°C,  $V_{cc}$  = 5.0 V  $\pm$  10%, unless otherwise noted.)

#### **Test Conditions**

Input pulse levels: 3.0 V/0.0 VInput rise and fall time: 3 ns

Input and output timing reference levels: 1.5 V
Output load: See figures (Including scope and jig)



#### Read Cycle

R1	RP	041	6DI
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		_				
Parameter	Symbol	Min Max		Unit	Notes	
Read cycle time	t <sub>RC</sub>	12	_	ns		
Address access time	t <sub>AA</sub>	_	12	ns		
Chip select access time	t <sub>ACS</sub>		12	ns		
Output enable to output valid	t <sub>oe</sub>	_	6	ns		
Byte select to output valid	t <sub>BA</sub>	_	6	ns		
Output hold from address change	t <sub>oh</sub>	3	_	ns		
Chip select to output in low-Z	t <sub>cLZ</sub>	3	_	ns	1	
Output enable to output in low-Z	t <sub>oLZ</sub>	0	_	ns	1	
Byte select to output in low-Z	t <sub>BLZ</sub>	0	_	ns	1	
Chip deselect to output in high-Z	t <sub>chz</sub>	_	6	ns	1	
Output disable to output in high-Z	t <sub>OHZ</sub>	_	6	ns	1	
Byte deselect to output in high-Z	t <sub>BHZ</sub>	_	6	ns	1	

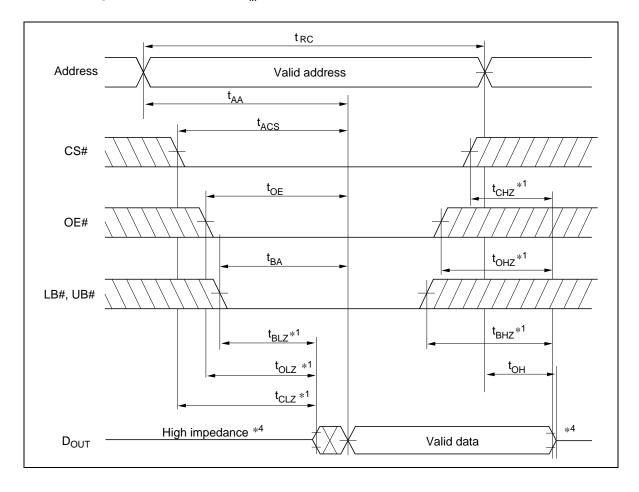
#### Write Cycle

		R1RP0	416DI		
		-2			
Parameter	Symbol	Min	Max	Unit	Notes
Write cycle time	t <sub>wc</sub>	12	_	ns	
Address valid to end of write	t <sub>AW</sub>	8	_	ns	
Chip select to end of write	t <sub>cw</sub>	8	_	ns	8
Write pulse width	t <sub>wP</sub>	8	_	ns	7
Byte select to end of write	t <sub>BW</sub>	8	_	ns	
Address setup time	t <sub>AS</sub>	0	_	ns	5
Write recovery time	t <sub>wR</sub>	0	_	ns	6
Data to write time overlap	t <sub>DW</sub>	6	_	ns	
Data hold from write time	t <sub>DH</sub>	0	_	ns	
Write disable to output in low-Z	t <sub>ow</sub>	3	_	ns	1
Output disable to output in high-Z	t <sub>ohz</sub>	_	6	ns	1
Write enable to output in high-Z	t <sub>whz</sub>	_	6	ns	1

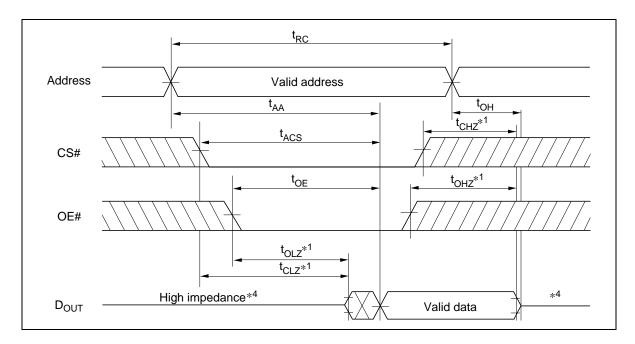
- Notes: 1. Transition is measured ±200 mV from steady voltage with output load (B). This parameter is sampled and not 100% tested.
  - 2. If the CS# or LB# or UB# low transition occurs simultaneously with the WE# low transition or after the WE# transition, output remains a high impedance state.
  - 3. WE# and/or CS# must be high during address transition time.
  - 4. If CS#, OE#, LB# and UB# are low during this period, I/O pins are in the output state. Then the data input signals of opposite phase to the outputs must not be applied to them.
  - 5. t<sub>AS</sub> is measured from the latest address transition to the latest of CS#, WE#, LB# or UB# going low.
  - 6.  $t_{wR}$  is measured from the earliest of CS#, WE#, LB# or UB# going high to the first address transition.
  - 7. A write occurs during the overlap of a low CS#, a low WE# and a low LB# or a low UB# ( $t_{wp}$ ). A write begins at the latest transition among CS# going low, WE# going low and LB# going low or UB# going low. A write ends at the earliest transition among CS# going high, WE# going high and LB# going high or UB# going high.
  - 8. t<sub>cw</sub> is measured from the later of CS# going low to the end of write.

## **Timing Waveforms**

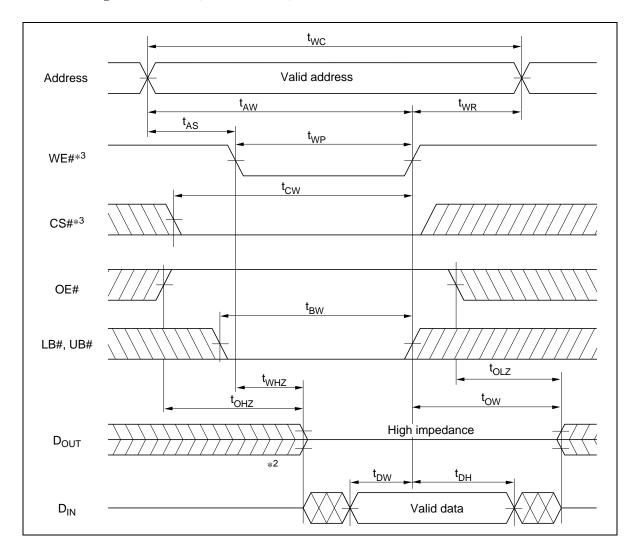
Read Timing Waveform (1) (WE# =  $V_{IH}$ )



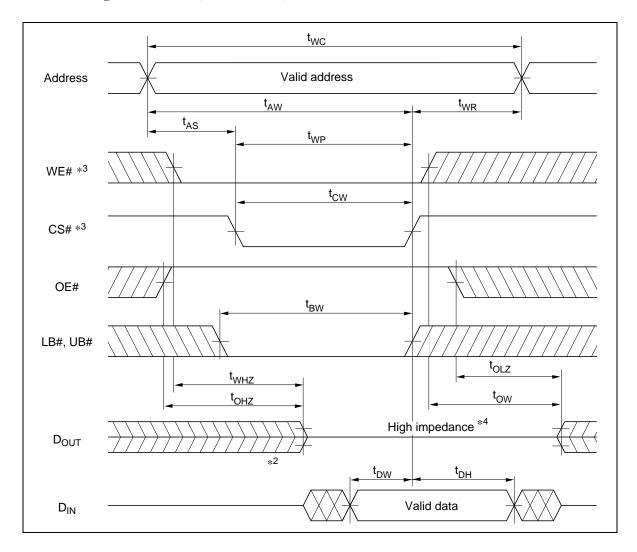
Read Timing Waveform (2) (WE# =  $V_{_{I\!H}},$  LB# =  $V_{_{I\!L}},$  UB# =  $V_{_{I\!L}})$ 



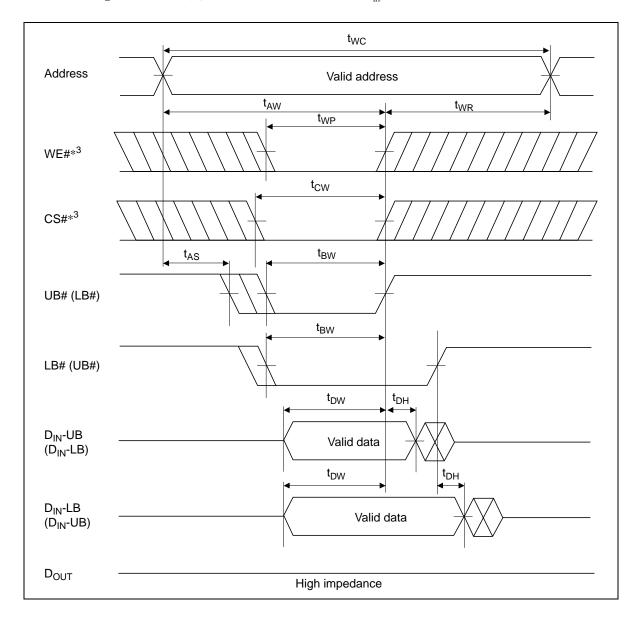
### Write Timing Waveform (1) (WE# Controlled)



### Write Timing Waveform (2) (CS# Controlled)



Write Timing Waveform (3) (LB#, UB# Controlled, OE# =  $V_{HH}$ )



# **Revision History**

# **R1RP0416DI Series Data Sheet**

Rev.	Date	Contents of Modification	
		Page	Description
0.01	Sep. 30, 2003	_	Initial issue
1.00	Mar.12.2004	_	Deletion of Preliminary

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